

International Face and Fingerprint Performance Conference 2025								
Tuesday April 1			Wednesday April 2			Thursday April 3		
	6:50	Welcome		6:50	Welcome		6:50	Welcome
		Face Session 1 (Chair: Patrick Grother)			Fingerprint Session 1: Quality + Statistical Models (Chair: Christoph Busch)			Face Session 3: Attack and Attack Detection (Chair: Mei Ngan)
1	7:00	Keynote: Arun Vemury (DHS S&T)	14	7:00	Greg Fiumara (NIST): NFIQ 2 v2.3 and the Future of ISO/IEC 29794-4	27	7:00	Jason Prince (Australia Home Affairs): Operational Experiences with Attack Detection
2	7:10	Kayee Hanaoka (NIST): FATE Age Estimation and Verification	15	7:25	Rudolf Haraksim (European Commission): JRC Workshops and the Development of ISO/IEC 29794-12	28	7:20	Mei Ngan (NIST): FATE MORPH
3	7:25	Austin Hom (NIST): FRTE Face in Video (FIVE) 2024	16	7:50	Christophe Champod (University of Lausanne): Fingerprint Quality Measures, Lights Out Transactions and Multi-modal Searches	29	7:35	Jeremy Dawson (WVU): CTeR High-Quality Morph Datasets
4	7:50	Joyce Yang (NIST): FATE Quality SIDD	17	8:15	Laurenz Ruzicka (AIT): Contactless Fingerprint Quality Assessment	30	8:00	Richard Marriott (IDEMIA): Robustness of Morphing Detection Algorithm to Compression
5	8:05	Johannes Merkle (secunet): Open Source Face Image Quality (OFIQ)	18	8:40	Tony Koertner (US Army): FRStat: Implementation and Utilization of a Statistical Model for Expressing Latent Print Evidence	31	8:25	Kiran Raja (NTNU): Morphing and Face Image Manipulations: Human versus Algorithm Detection Performance
6	8:30	Javier Galbally (eu-LISA): Operational Need for Face Image Quality	19	9:05	Eric Ray (IDEMIA): Likelihood Ratio Model in AFIS	32	8:50	Arun Vemury (DHS S&T), Richard Plesh (SAIC), and Yevgeniy Sirotn (SAIC): Remote Identity Verification: Framework and Results
7	8:55	Jim Wayman (Principal UK Expert): Face and Fingerprint: Reconciling Differing Concepts of Biometric Image Quality						
	9:20	Break		9:30	Break		9:30	Break
		Face Session 2: Standards + Risk Management (Chair: Patrick Grother)			Fingerprint Session 2: New Developments + Industry Perspectives (Chair: Gregory Fiumara)			Face Session 4: New Developments + Industry Perspectives (Chair: Patrick Grother)
8	9:45	Patrick Grother (NIST): Overview of ISO/IEC JTC1 SC37	20	9:45	Greg Fiumara (NIST): FRIF TE	33	9:45	Chris Bonn (Finnish Immigration Service) and R. Rajeshkumar (Auctorizium): 1KB Face Images on 2D barcodes
9	10:00	Kévin Carta (Cabinet Louis Reynaud): Injection attack: a major threat against remote identity verification	21	9:57	Shahram Orandi (NIST): Contactless Certification: Calibration Targets	34	10:10	Patrick Grother (NIST): Face Recognition Accuracy Effects When Compressing Face Images to QR Code Size 1KB
10	10:25	Arun Vemury (DHS S&T) and John Howard (SAIC): Operational Testing of Face Recognition Systems: Challenges, New Approaches and Developing International Standards	22	10:10	Bethany Retton (FBI CJIS): Current Fingerprint Initiatives at FBI's Criminal Justice Information Services (CJIS) Division	35	10:30	Surendra Singh (Clarkson University) + Stephanie Schuckers (UNC Charlotte): Longitudinal Evaluation of Child Face Recognition
11	10:45	Ralph Lessmann (HID Global): ISO/IEC 39794-x and Adoption in ICAO 9303	23	10:35	Tom Michalsky (IDloop): 3D Fingerprint Recognition	36	10:55	Anderson Rocha (Recod.ia): Deepfakes and Deepfake Detection
12	11:10	Udo Mahlmeister (CLEAR): ISO/IEC 25447 Less Constrained Face Capture	24	11:00	Igor Janos (Innovatrics): Pushing the Limits of Latent Fingerprint Identification with Synthetic Data	37	11:20	Brendan Klare (ROC): Challenges and Opportunities in Face Recognition
13	11:35	Marta Gomez-Barrero (U. der Bundeswehr München): ISO/IEC 30136 Performance Testing of Template Protection Schemes	25	11:25	Evaldas Borcovas (Neurotechnology): The Role of AI in Fingerprint Recognition: From Image Enhancement to Feature Extraction - Different Features for Different Domains (Civil & Criminal)	38	11:45	Patrick Grother (NIST): FRTE / FATE: What's Next
			26	11:50	Josh Engelsma (ROC): Implications of Next Generation Fingerprint Technologies		12:00	
Time	7:00	Washington DC (EDT)		16:00	Dubai		21:00	Tokyo
Zones	12:00	London		17:30	Delhi		22:00	Sydney
	13:00	Brussels		21:00	Seoul		1:00	Auckland